

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL TYPE (PCT PROCESS)

2SC2983

POWER AMPLIFIER APPLICATIONS

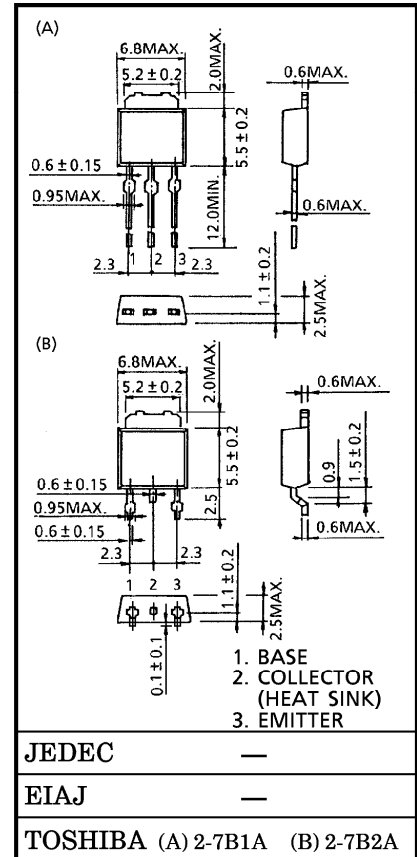
DRIVER STAGE AMPLIFIER APPLICATIONS

- High Transition Frequency : $f_T = 100 \text{ MHz (Typ.)}$
- Complementary to 2SA1225

MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

| CHARACTERISTIC | SYMBOL | RATING | UNIT |
|-----------------------------|-----------|--------------------------|------------------|
| Collector-Base Voltage | V_{CB0} | 160 | V |
| Collector-Emitter Voltage | V_{CE0} | 160 | V |
| Emitter-Base Voltage | V_{EB0} | 5 | V |
| Collector Current | I_C | 1.5 | A |
| Base Current | I_B | 0.3 | A |
| Collector Power Dissipation | P_C | $T_a = 25^\circ\text{C}$ | 1.0 |
| | | $T_c = 25^\circ\text{C}$ | 15 |
| Junction Temperature | T_j | 150 | $^\circ\text{C}$ |
| Storage Temperature Range | T_{stg} | -55~150 | $^\circ\text{C}$ |

Unit in mm



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Weight : 0.36 g

| CHARACTERISTIC | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|--------------------------------------|-----------------|---|------|------|------|---------------|
| Collector Cut-off Current | I_{CBO} | $V_{CB} = 160 \text{ V}, I_E = 0$ | — | — | 1.0 | μA |
| Emitter Cut-off Current | I_{EBO} | $V_{EB} = 5 \text{ V}, I_C = 0$ | — | — | 1.0 | μA |
| Collector-Emitter Breakdown Voltage | $V_{(BR)CE0}$ | $I_C = 10 \text{ mA}, I_B = 0$ | 160 | — | — | V |
| Emitter-Base Breakdown Voltage | $V_{(BR)EBO}$ | $I_E = 1 \text{ mA}, I_C = 0$ | 5 | — | — | V |
| DC Current Gain | h_{FE} (Note) | $V_{CE} = 5 \text{ V}, I_C = 100 \text{ mA}$ | 70 | — | 240 | |
| Collector-Emitter Saturation Voltage | $V_{CE(sat)}$ | $I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$ | — | — | 1.5 | V |
| Base-Emitter Voltage | V_{BE} | $V_{CE} = 5 \text{ V}, I_C = 500 \text{ mA}$ | — | — | 1.0 | V |
| Transition Frequency | f_T | $V_{CE} = 10 \text{ V}, I_C = 100 \text{ mA}$ | — | 100 | — | MHz |
| Collector Output Capacitance | C_{ob} | $V_{CB} = 10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$ | — | 25 | — | pF |

Note : h_{FE} Classification O : 70~140, Y : 120~240

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